

<b>Notice of References Cited</b>	Application/Control No. 10/786,072	Applicant(s)/Patent Under Reexamination ISHII ET AL.	
	Examiner Patrick A. Darno	Art Unit 2163	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2005/0091658 A1	04-2005	Kavalam et al.	718/104
*	C	US-5,260,551	11-1993	Wiik et al.	340/5.28
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	M	US-			

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**NON-PATENT DOCUMENTS**

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